BOX PCT

IN THE UNITED STATES ELECTED OFFICE OF THE UNITED STATES PATENT AND TRADEMARK OFFICE UNDER THE PATENT COOPERATION TREATY-CHAPTER II

5 APPLICANT(S):

Anton Enterrottacher et al.

DOCKET NO:

P00,0637

INTERNATIONAL APPLICATION NO:

PCT/DE99/00415

INTERNATIONAL FILING DATE:

16 February 1999

INVENTION: AUTHENTICATION OF KEY DEVICES

10 Assistant Commissioner for Patents, Washington, D.C. 20231

INFORMATION DISCLOSURE STATEMENT

Sir:

In accordance with the provisions of 37 C.F.R. §1.56 and the requirements of 37 C.F.R. §1.98, Applicant respectfully requests that consideration and citation of the following documents be made during the course of examination of the above-identified application.

		·				
	AA	U.S. Patent 5,638,447				
	AB	U.S. Patent 5,402,490				
20	Al	International application WO 97/48208				
	AJ	French reference FR 2 709 903				
	AK	International application WO 95/14283				
	AL	Japanese reference JP 09-298537				
	AQ	W. Fumy et al., "Kryptographie, Entwurf und Analyse				
25		symmetrischer Kryptosysteme, R. Oldenbourg Verlag				
		Muenchen Wien 1988, ISBN 3-486-20868-3				
		pages 287-291				

EXPLANATION OF RELEVANCE

References AI, AJ and AK were cited during earlier examination of the present PCT application. Therefore, no further commentary concerning their teachings is necessary.

5

Reference AQ has been described on page 1 of the present application. Accordingly, no further commentary concerning the teachings of this references are believed to be necessary.

10

References AA, AB and AL are further prior art references known to the Applicants. Since references AA and AB are United States Patents, no further commentary concerning their teachings is necessary. Reference AL, which is a Japanese reference, includes an attached English Abstract. Accordingly, no further commentary concerning its teachings is believed necessary.

Copies of each of the above references together with Form 1449 and the European Search Report are submitted herewith.

15

20

The Information Disclosure Statement is being filed concurrently with the present application, and is therefore in compliance with 37 C.F.R. §1.97(b)(1) and no fee is necessary.

The above citation of prior art is not a representation that such art constitutes a complete or exhaustive listing of all pertinent prior art, nor that it necessarily includes the closest or most relevant art. The aforementioned citation comprises a voluntary citation of prior art of which Applicants are presently aware and is not intended to serve as a substitute for the Examiner's own search.

Respectfully submitted,

25

Mark Bergner

(Reg. No. 45,877)

SCHIFF HARDIN & WAITE PATENT DEPARTMENT

6600 Sears Tower

Chicago, Illinois 60606-6473

(312) 258-5779

Attorneys for Applicant

30

430 Rec'd PCT/PTO 1 4 SEP 2009

PCT/DE99/00415

Sheet <u>1</u> of <u>1</u>

Form P.T.O. 1449		U.S. Department of Commerce Patent and Trademark Office			Docket No. P00,0637		Serial No. New Application			
LIST OF PRIOR ART CITED BY APPLICANT (use several sheets if necessary)					Applicant(s) Anton Enterrottacher et al.					
					Filing Date Herewith		Group Art Unit			
			U.S. PATI	ENT DOCUMENTS						
Examiner's Initials	er's Document		Date	Name	Class Subclass		Filing Date If appropriate			
	AA	5,638,447				5400,455	11 4551	эргин		
	AB	5,402,490	28 Mar 1995	Mihm, Jr.	1					
	AC									
	AD									
	AE									
	AF									
	AG									
	AH									
			FOREIGN PA	ATENT DOCUMENTS						
							Translation			
	<u> </u>	Document Number	Date	Country	Class	Subclass	Yes	No		
	AI	WO 97/48208	18 Dec 1997	PCT						
	AJ	FR 2 709 903	17 Mar 1995	France						
	AK	WO 95/14283	26 May 1995	PCT				<u> </u>		
	AL	JP 09-298537	18 Nov 1997	Japanese						
	AM									
	AN									
	AO									
	AP -									
		OTHER PRIOR A	RT (Including	Author, Title, Date, Per	tinent Pag	es, Etc.)				
	AQ	W. Fumy et al., "Kryptographie, Entwurf und Analyse symmetrischer Kryptosysteme, R. Oldenbourg Verlag Muenchen Wien 1988, ISBN 3-486-20868-3 pages 287-291								
	AR									
	AS									
	AT									
	AU									
	AV							•		
Examiner		Date Considered								
*EXAMINEI through citat applicant.	R: Initia	al if reference conside ot in conformance and	red, whether o	or not citation is in confo d. Include copy of this f	ormance with r	ith MPEP 60s	9. Draw linication to	ne		